Rev.2.0

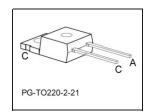
ating;	RoHS con	npl	Ia	nt
dina ta		⁾ fc	or	tard

Fast Switching EmCon Diode				
Feature				
 1200 V EmCon technology 				

- Fast recovery
- Soft switching
- Low reverse recovery charge
- Low forward voltage
- Easy paralleling
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC⁽⁰⁾ for target applications



r roddot oanniary					
V _{RRM}	1200	V			
/ _F	12	А			
V _F	1.65	V			
T _{jmax}	150	°C			



Туре	Package	Marking	Pin 1	PIN 2	
IDH12E120	PG-TO220-2-21	D12E120	С	А	-

Maximum Ratings, at $T_i = 25$ °C, unless otherwise specified

Parameter	Symbol	Value	Unit
Repetitive peak reverse voltage	V _{RRM}	1200	V
Continous forward current	/ _F		A
<i>T</i> _C =25°C		28	
<i>T</i> _C =90°C		17	
Surge non repetitive forward current	/ _{FSM}	63	
$T_{\rm C}$ =25°C, $t_{\rm p}$ =10 ms, sine halfwave			
Maximum repetitive forward current	/ _{FRM}	42.5	
T _C =25°C, <i>t</i> _p limited by <i>T</i> _{jmax} , <i>D</i> =0.5			
Power dissipation	P _{tot}		W
<i>T</i> _C =25°C		96	
<i>T</i> _C =90°C		46	
Operating and storage temperature	T _i , T _{stg}	-55+150	°C
Soldering temperature wavesoldering, 1.6mm (0.063 in.) from case for 10s	T _S	260	°C

⁰ J-STD20 and JESD22

IDH12E120





Thermal Characteristics

Parameter	Symbol	Values		Unit	
		min.	typ.	max.	
Characteristics					
Thermal resistance, junction - case	R _{thJC}	-	-	1.3	K/W
Thermal resistance, junction - ambient, leaded	R _{thJA}	-	-	62	

Parameter	Symbol	Values		Unit	
		min.	typ.	max.	
Static Characteristics			-		-
Reverse leakage current	/ _R				μA
V _R =1200V, <i>T</i> _j =25°C		-	-	100	
V _R =1200V, <i>T</i> _j =150°C		-	-	1000	
Forward voltage drop	V _F				V
/ _F =12A, <i>T</i> _j =25°C		-	1.65	2.15	
/ _F =12A, <i>T</i> _j =150°C		_	1.7	_	

Electrical Characteristics, at T_i = 25 °C, unless otherwise specified

¹Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical without blown air.

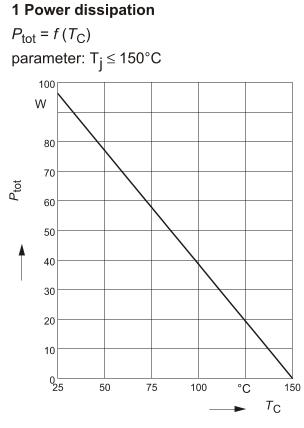


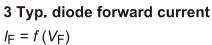
Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Dynamic Characteristics					
Reverse recovery time	t _{rr}				ns
V _R =800V, <i>I</i> _F =12A, d <i>i</i> _F /d <i>t</i> =800A/μs, <i>T</i> _j =25°C		-	150	-	
V _R =800V, <i>I</i> _F =12A, d <i>i</i> _F /d <i>t</i> =800A/μs, <i>T</i> _j =125°C		-	215	-	
V _R =800V, / _F =12A, d <i>i</i> _F /d <i>t</i> =800A/μs, 7 _j =150°C		-	225	-	
Peak reverse current	/ _{rrm}				А
V _R =800V, <i>I</i> _F = 12 A, d <i>i</i> _F /d <i>t</i> =800A/µs, <i>T</i> _j =25°C		-	17	-	
V _R =800V, <i>I</i> _F =12A, d <i>i</i> _F /d <i>t</i> =800A/µs, <i>T</i> _j =125°C		-	20.9	-	
V _R =800V, <i>I</i> _F =12A, d <i>i</i> _F /d <i>t</i> =800A/µs, <i>T</i> _j =150°C		-	21.5	-	
Reverse recovery charge	Q _{rr}				nC
V _R =800V, <i>I</i> _F =12A, d <i>i</i> _F /d <i>t</i> =800A/μs, <i>T</i> _j =25°C		-	1200	-	
V _R =800V, <i>I</i> _F =12A, d <i>i</i> _F /d <i>t</i> =800A/µs, <i>T</i> _j =125°C		-	1840	-	
$V_{\rm R}$ =800V, $I_{\rm F}$ =12A, $di_{\rm F}/dt$ =800A/µs, $T_{\rm j}$ =150°C		-	2025	-	
Reverse recovery softness factor	S				
V _R =800V, <i>I</i> _F =12A, d <i>i</i> _F /d <i>t</i> =800A/μs, <i>T</i> _j =25°C		-	5	-	
V _R =800V, / _F =12A, d <i>i</i> _F /d <i>t</i> =800A/µs, 7 _j =125°C		-	5.8	-	
V _R =800V, I _F =12A, d <i>i</i> _F /d <i>t</i> =800A/µs, <i>T</i> _i =150°C		-	5.9	-	

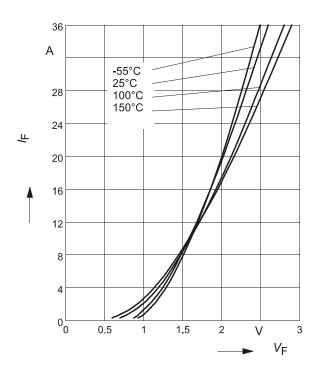
Electrical Characteristics, at T_i = 25 °C, unless otherwise specified



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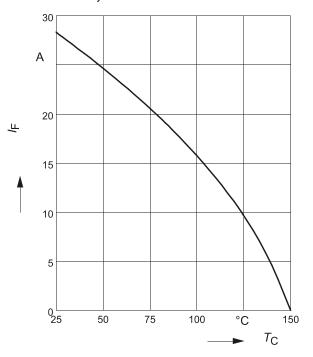




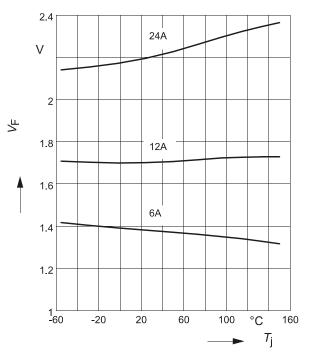


2 Diode forward current $I_{\rm F} = f(T_{\rm C})$

parameter: $T_{i} \le 150^{\circ}C$



4 Typ. diode forward voltage $V_{\rm F} = f(T_{\rm j})$



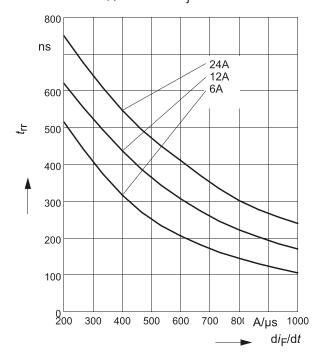
2007-02-26



5 Typ. reverse recovery time

 $t_{\rm rr} = f \left({\rm d}i_{\rm F} / {\rm d}t \right)$

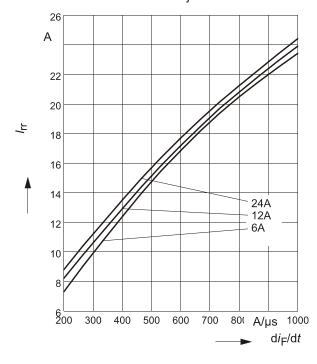
parameter: V_R = 800V, T_i = 125°C



7 Typ. reverse recovery current

 $I_{\rm rr} = f \left({\rm d}i_{\rm F} / {\rm d}t \right)$

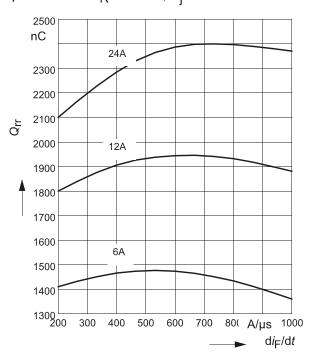
parameter: V_R = 800V, T_i = 125°C



IDH12E120

6 Typ. reverse recovery charge Q_{rr}=*f*(d*i*_F/d*t*)

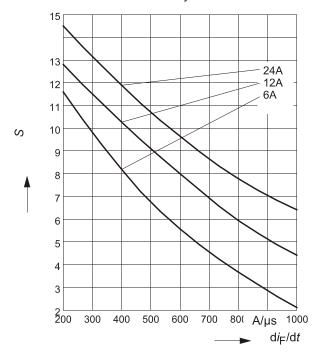
parameter: $V_{\rm R}$ = 800V, $T_{\rm i}$ = 125 °C



8 Typ. reverse recovery softness factor

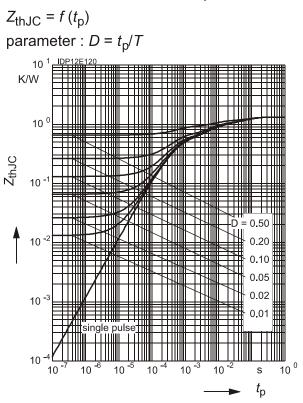
 $S = f(di_F/dt)$

parameter: V_R = 800V, T_i = 125°C



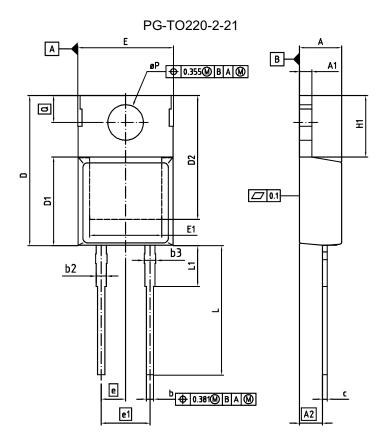


9 Max. transient thermal impedance



IDH12E120





	dimensions				
symbol	[mm] [ir		[mm] [incl		
-	min	max	min	max	
А	4.191	4.699	0.165	0.185	
A1	1.219	1.321	0.048	0.052	
A2	2.387	2.489	0.094	0.098	
b	0.635	0.889	0.025	0.035	
b2	1.143	1.397	0.045	0.055	
b3	1.143	1.651	0.045	0.065	
С	0.331	0.635	0.013	0.025	
D	15.113	15.621	0.595	0.615	
D1	9.017	9.271	0.355	0.365	
D2	13.737	14.245	0.541	0.561	
E	9.677	9.931	0.381	0.391	
E1	8.28	8.788	0.324	0.346	
е	2.5	2.54		.1	
e1	5.029	5.131	0.198	0.202	
H1	6.096	6.35	0.24	0.25	
L	12.802	13.31	0.504	0.524	
L1	3.048	3.302	0.12	0.13	
P	3.632	3.734	0.143	0.147	
Q	2.54	3.048	0.1	0.12	



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